

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/743,170	ESPERESTER	ET AL.
Examiner	Art Unit	
Patricia Leith	1655	

	SEAR	CHED	
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST:JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCRBACKFILE updated	3/14/2008	PL
Inventor name search updated EAST/PALM	3/14/2008	PL